

CE EMC TEST REPORT

On Behalf of

Shenzhen su di technology co. LTD

Product Name: IPL photon skin rejuvenation and depilation instrumen

Trademark: N/A

Model Number: TMY-002, Y1, Y2.

Prepared For: Shenzhen su di technology co. LTD

Address: 5 / f, building B, dadongming science park, changzhen community, gongming office, guangming new district, shenzhen

Prepared By: Shenzhen BKC Testing Co., Ltd.

Address: 6/F, Building 3, Zhouteng Industrial Park, Nanwan Street, Longgang District, Shenzhen, Guangdong, China.

Test Date: Jun. 17, 2020 - Jun. 29, 2020

Date of Report : Jun. 29, 2020

Report No.: BKC201272ER

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Shenzhen BKC Testing Co., Ltd.

Applicant : Shenzhen su di technology co. LTD
Address : 5 / f, building B, dadongming science park, changzhen community, gongming office, guangming new district, shenzhen
Manufacturer : Shenzhen su di technology co. LTD
Address : 5 / f, building B, dadongming science park, changzhen community, gongming office, guangming new district, shenzhen
EUT : IPL photon skin rejuvenation and depilation instrumen
Model Number : TMY-002
Trademark: : N/A
Test Date : Jun. 17, 2020 - Jun. 29, 2020
Date of Report : Jun. 29, 2020
Test Result: : The equipment under test was found to be compliance with the requirements of the standards applied.
Test Procedure Used:
EMI : EN 55014-1:2017
EN IEC 61000-3-2:2019, EN 61000-3-3:2013+A1:2019
EMS : EN 55014-2:2015
EN 61000-4-2:2009, EN 61000-4-3:2006+A1:2008+A2:2010
EN 61000-4-4:2012, EN 61000-4-5:2014+A1:2017
EN 61000-4-6:2014, EN 61000-4-11:2004+A1:2017

Prepared by(Test Engineer):
Denise Tan



Reviewer(Supervisor):
Vincent mei



Approved(Manager):
Corbin wang



1. GENERAL INFORMATION

1.1. Description of Device (EUT)

EUT : IPL photon skin rejuvenation and depilation instrumen

Model Number : TMY-002

Model Difference : The product is different for model name and outlook, color.

Trademark: : N/A

Power Supply : DC12V 2000mA (with external adapter)

Work Frequency : Below 108MHz

Note: TMY-002 was selected as the test model and the datas have been recorded in this report.

1.2. Tested System Details

Personal Computer : DELL Monitor : SONY

M/N : INSPIRON M/N : MNT1

Printer : EPSON STYLUS Keyboard (USB) : Genuine

M/N : P320A M/N : N/A

Modem : ACEEX Mouse : DETROIS

M/N : DM-1414 M/N : CM309

1.3. Test Uncertainty

Conducted Emission Uncertainty : ± 2.48 dB

Radiated Emission Uncertainty : ± 4.14 dB

1.4. Test Facility

Site Description

Name of Firm : Shenzhen BKC Testing Co., Ltd.

Site Location : 6/F, Building 3, Zhouteng Industrial Park, Nanwan Street,
Longgang District, Shenzhen, Guangdong, China.



2. TEST INSTRUMENT USED

2.1 CONDUCTED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	LISN	R&S	ENV216	101313	Nov. 13, 2020
2	LISN	EMCO	3816/2	00042990	Nov. 13, 2020
3	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Nov. 13, 2020
4	EMI Test Receiver	R&S	ESCI	101160	Nov. 13, 2020
5	Passive Voltage Probe	ESH2-Z3	R&S	100196	Nov. 13, 2020
6	Triple-Loop Antenna	EVERFINE	LIA-2	11020003	Nov. 13, 2020
7	Absorbing Clamp	R&S	MDS-21	100423	Nov. 13, 2020
8	Coupling/ Decoupling Network	PH	ISN T800	S1509001	Nov. 13, 2020

2.2 DISTURBANCE POWER

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	EMI Test Receiver	R&S	ESCI	101160	Nov. 13, 2020
2	Power Clamp	LUTHI	MDS21	4293	Nov. 13, 2020
3	Attenuator	R&S	ESH3-Z2	BCW021E	Nov. 13, 2020

2.3 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Bilog Antenna	TESEQ	CBL6111D	31216	Nov. 13, 2020
2	EMI Test Receiver	R&S	ESCI-7	101318	Nov. 13, 2020
3	Antenna Mast	EM	SC100_1	N/A	Nov. 13, 2020
4	50Ω Switch	Anritsu Corp	MP59B	6200983705	Nov. 13, 2020
5	Spectrum Analyzer	Agilent	E4407B	MY45108040	Nov. 13, 2020
6	Horn Antenna	EM	EM-AH-1018 0	2011071402	Nov. 13, 2020
7	Amplifier	EM	EM-30180	060538	Nov. 13, 2020

2.4 HARMONICS AND FILCKER

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Nov. 13, 2020
2	AC Power Source	EM TEST	ACS500	0203-01	Nov. 13, 2020

2.5 ELECTROSTATIC Discharge

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	ESD TEST GENERATOR	EVERFINE	EMS61000-2 A-V200	11040001T	Nov. 13, 2020

2.6 RS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	R&S	SMT 06	832080/007	Nov. 13, 2020
2	Log-Bicon Antenna	Schwarzbeck	VULB9161	4022	Nov. 13, 2020
3	Power Amplifier	AR	150W1000M1	320946	Nov. 13, 2020
4	Microwave Horn Antenna	AR	AT4002A	321467	Nov. 13, 2020
5	Power Amplifier	AR	25S1G4A	308598	Nov. 13, 2020

2.7 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

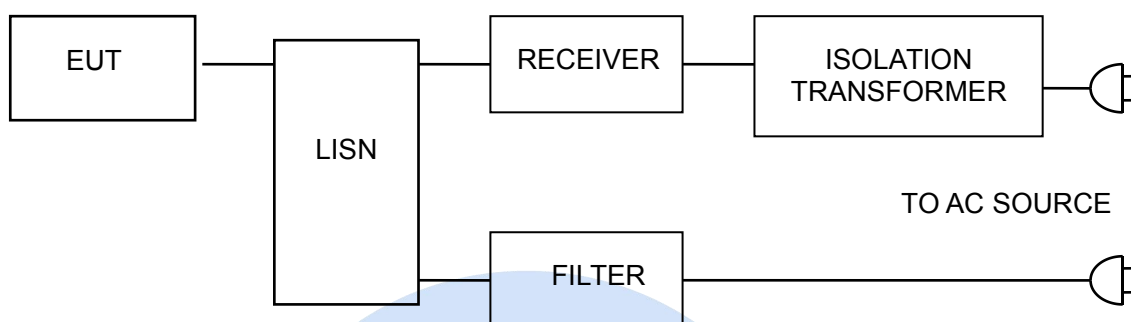
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Surge Generator	EVERFINE	EMS61000-5 A	1101002	Nov. 13, 2020
2	DIPS Generator	EVERFINE	EMS61000-11 K	1011002	Nov. 13, 2020
3	EFT/B Generator	Schaffner	MODULA615 0	34437	Nov. 13, 2020

2.8 INJECTION CURRENT

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	IFR	2023A	202301/368	Nov. 13, 2020
2	Power Amplifier	AR	75A250AM1	0320709	Nov. 13, 2020
3	CDN	FCC	FCC-801-M2	06043	Nov. 13, 2020
4	EM Clamp	FCC	F-2031-23MM	504	Nov. 13, 2020

3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

3.1. Block Diagram Of Test Setup



3.2. Test Standard

EN 55014-1:2017

3.3. Power Line Conducted Emission Limit

Frequency MHz	Limits dB(μ V)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

3.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55014-1 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5. Operating Condition of EUT

3.5.1 Setup the EUT and simulators as shown in Section 3.1.

3.5.2 Turn on the power of all equipments.

3.5.3 Let the EUT work in test modes and test it.

3.6. Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **EN 55014-1** regulations during conducted emission test.

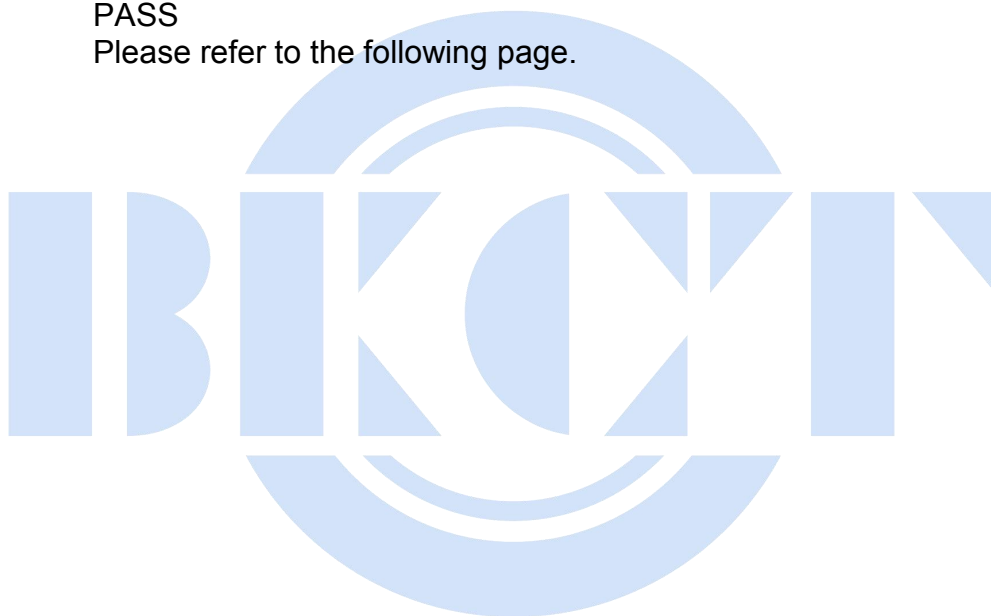
The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

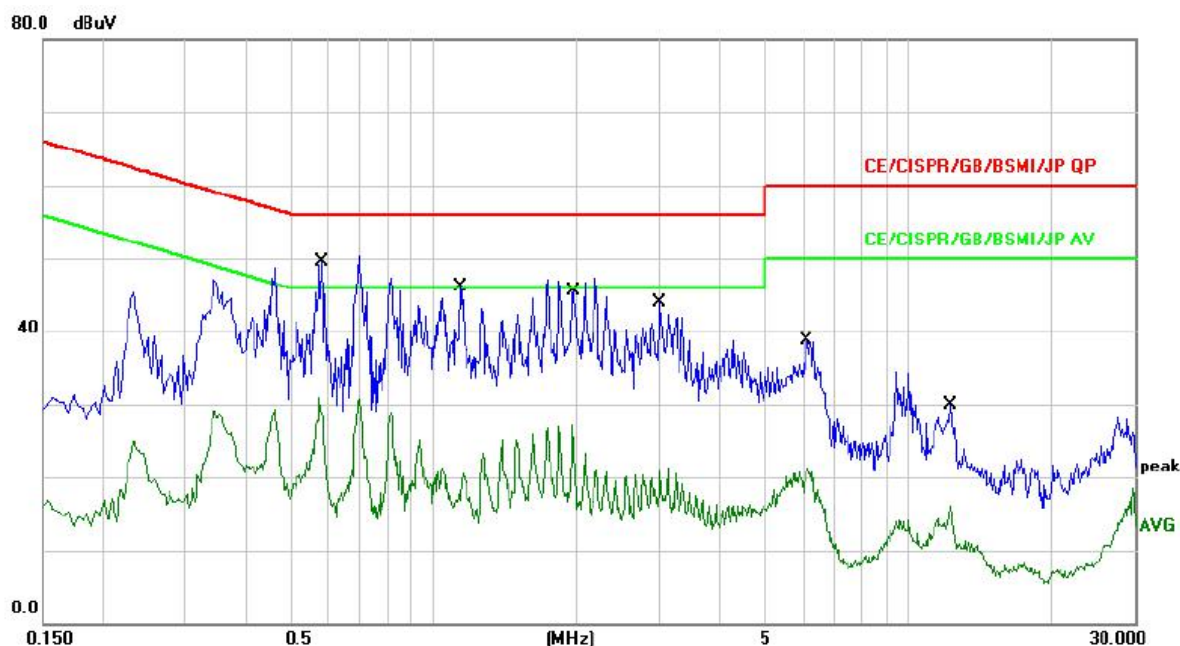
3.7. Test Result

PASS

Please refer to the following page.

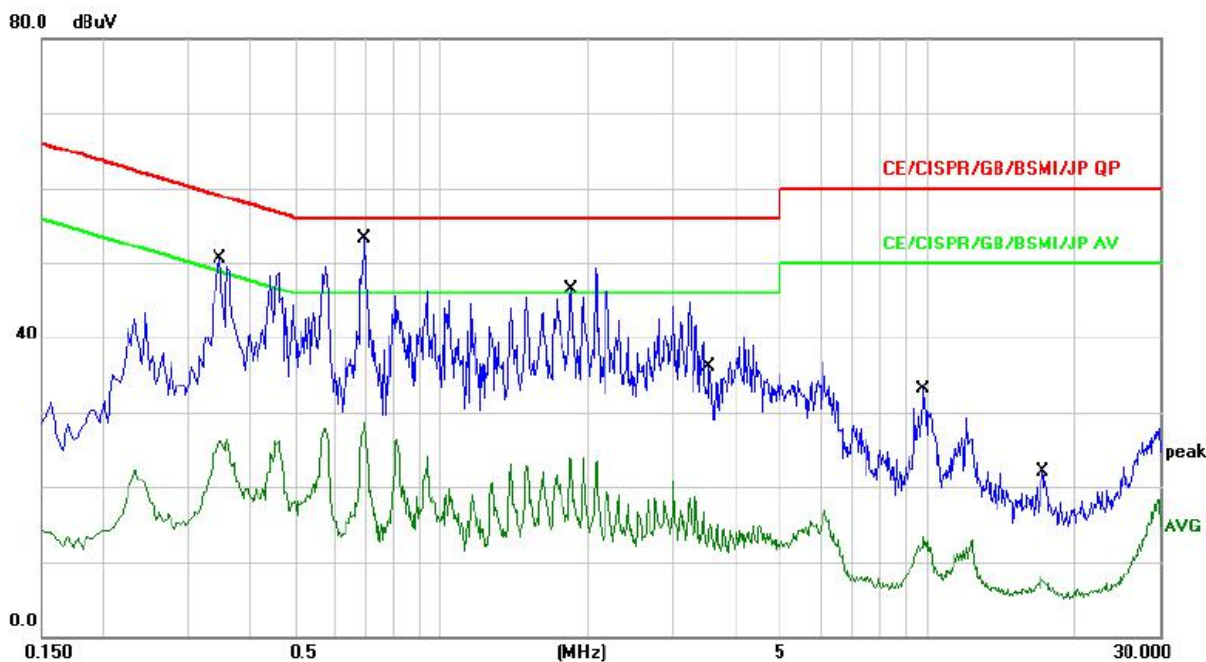


Conducted Emission At The Mains Terminals Test Data			
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Line
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1	*	0.5740	39.45	10.12	49.57	56.00	-6.43	QP	
2		0.5740	20.79	10.12	30.91	46.00	-15.09	AVG	
3		1.1380	35.86	10.17	46.03	56.00	-9.97	QP	
4		1.1380	13.12	10.17	23.29	46.00	-22.71	AVG	
5		1.9660	37.11	10.18	47.29	56.00	-8.71	QP	
6		1.9660	16.84	10.18	27.02	46.00	-18.98	AVG	
7		3.0020	33.75	10.19	43.94	56.00	-12.06	QP	
8		3.0020	11.08	10.19	21.27	46.00	-24.73	AVG	
9		6.1020	28.67	10.09	38.76	60.00	-21.24	QP	
10		6.1020	11.28	10.09	21.37	50.00	-28.63	AVG	
11		12.3139	19.80	10.13	29.93	60.00	-30.07	QP	
12		12.3139	5.97	10.13	16.10	50.00	-33.90	AVG	

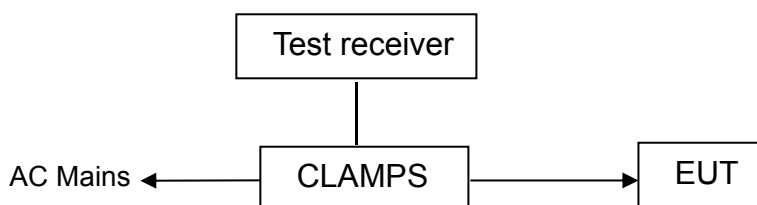
Conducted Emission At The Mains Terminals Test Data			
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Neutral
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode



No. Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measurement dBuV	Limit dBuV	Over dB	Detector	Comment
1	0.3500	40.32	10.10	50.42	58.96	-8.54	QP	
2	0.3500	16.19	10.10	26.29	48.96	-22.67	AVG	
3 *	0.6940	43.14	10.13	53.27	56.00	-2.73	QP	
4	0.6940	18.67	10.13	28.80	46.00	-17.20	AVG	
5	1.8460	39.07	10.18	49.25	56.00	-6.75	QP	
6	1.8460	13.80	10.18	23.98	46.00	-22.02	AVG	
7	3.5740	29.99	10.17	40.16	56.00	-15.84	QP	
8	3.5740	4.98	10.17	15.15	46.00	-30.85	AVG	
9	9.8580	23.07	10.12	33.19	60.00	-26.81	QP	
10	9.8580	3.08	10.12	13.20	50.00	-36.80	AVG	
11	17.1900	11.91	10.16	22.07	60.00	-37.93	QP	
12	17.1900	-2.17	10.16	7.99	50.00	-42.01	AVG	

4. DISTURBANCE POWER TEST

4.1. Block Diagram Of Test Setup



4.2. Test Standard

EN 55014-1:2017

4.3. Disturbance Power Limit

All emanations from devices or system including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

Frequency MHz	Interference Power Limits dB(pW)	
	Quasi-peak Value	Average Value
30 ~ 300	45 ~55	35 ~ 45
Increasing linearly with the frequency.		

4.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55014-1 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

4.5. Operating Condition of EUT

- 3.5.1 Setup the EUT and simulators as shown in Section 3.1.
- 3.5.2 Turn on the power of all equipments.
- 3.5.3 Let the EUT work in test modes and test it.

4.6. Test Procedure

The EUT is placed on the ground and away from other metallic surface at least 0.4m. It is connected to the power mains through an extension cord of 6m. The absorber clamp clamps the cord and moves from the far end to the EUT to measure the disturbing energy emitted from the cord.

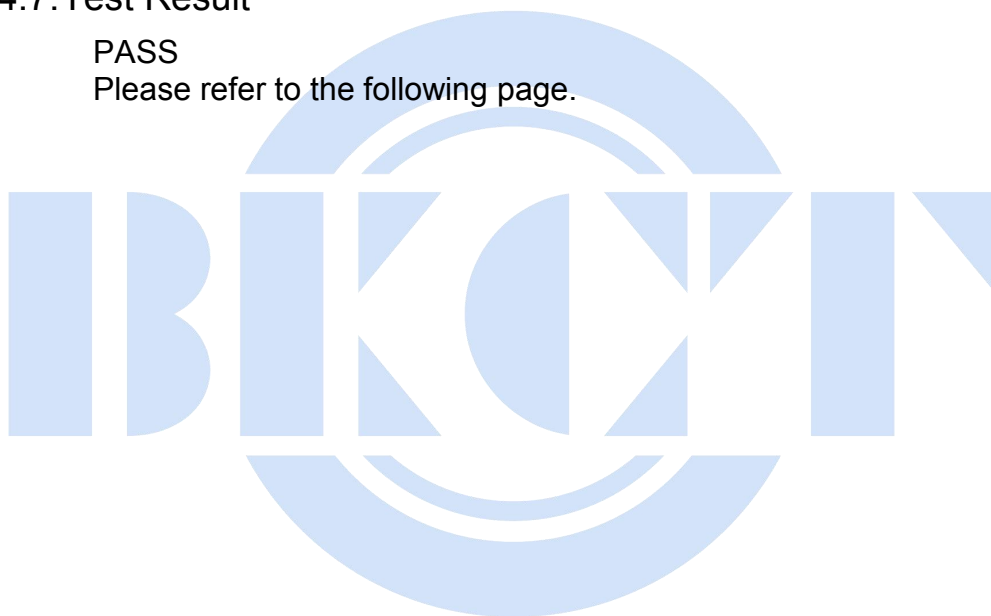
The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 120KHz.

The frequency range from 30 MHz to 300 MHz is investigated.

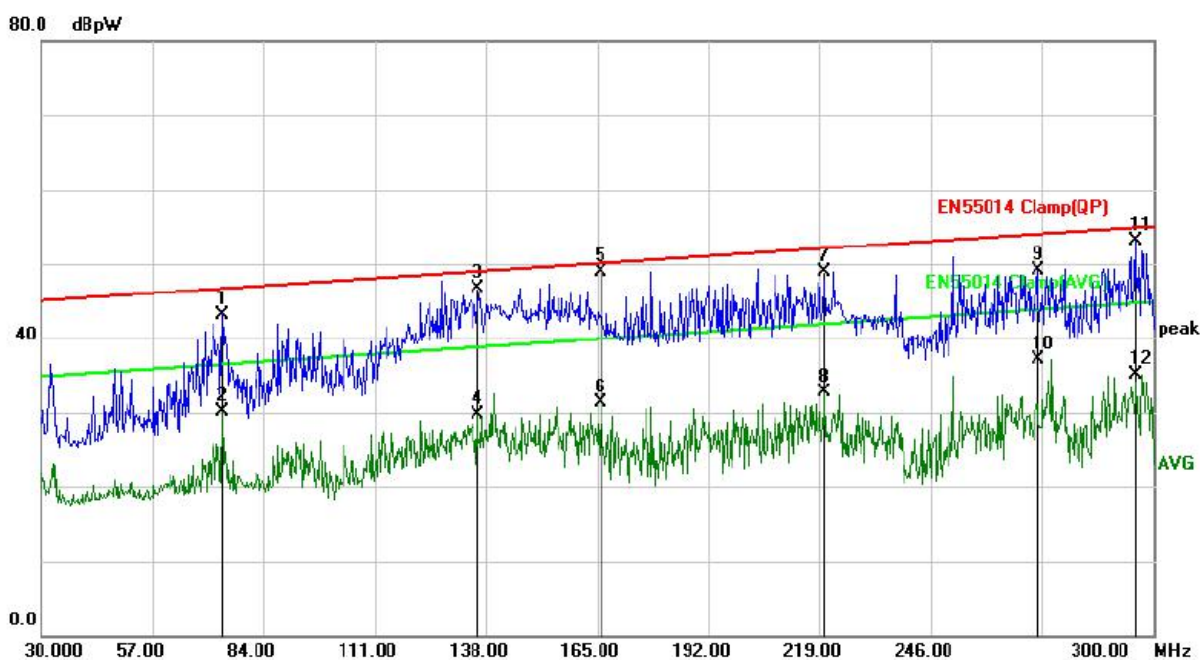
4.7. Test Result

PASS

Please refer to the following page.



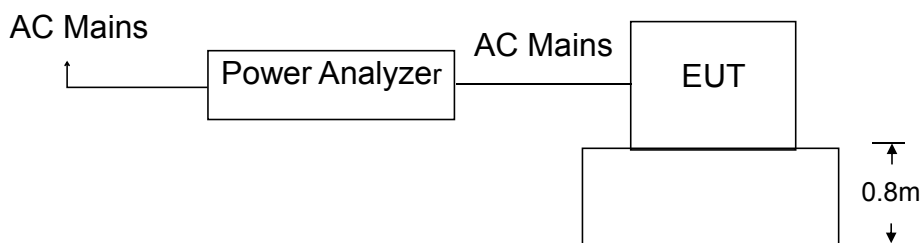
Disturbance Power Test Data			
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Line
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode



No.	Mk.	Freq. MHz	Reading Level dBpW	Correct Factor dB	Measure- ment dBpW	Limit dBpW	Over dB	Detector	Position cm	Comment
1		74.0100	17.78	25.42	43.20	46.63	-3.43	QP		
2		74.0100	4.68	25.42	30.10	38.92	-8.82	AVG		
3		135.8400	21.11	25.51	46.62	48.92	-2.30	QP		
4		135.8400	4.29	25.51	29.80	41.56	-11.76	AVG		
5	*	165.8100	23.94	25.03	48.97	50.03	-1.06	QP		
6		165.8100	6.22	25.03	31.25	42.42	-11.17	AVG		
7		220.3500	23.88	24.96	48.84	52.05	-3.21	QP		
8		220.3500	7.68	24.96	32.64	43.66	-11.02	AVG		
9		271.9200	24.12	24.97	49.09	53.96	-4.87	QP		
10		271.9200	12.22	24.97	37.19	44.57	-7.38	AVG		
11		295.6800	26.53	26.48	53.01	54.84	-1.83	QP		
12		295.6800	8.71	26.48	35.19	44.94	-9.75	AVG		

5. HARMONIC CURRENT EMISSION TEST

5.1. Block Diagram of Test Setup



5.2. Test Standard

EN IEC 61000-3-2:2019

5.3. Operating Condition of EUT

- 5.1.1 Setup the EUT as shown in Section 5.1.
- 5.1.2 Turn on the power of all equipments.
- 5.1.3 Let the EUT work in test mode and test it.

5.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

5.5. Test Results

PASS.

6. VOLTAGE FLUCTUATIONS & FLICKER TEST

6.1. Block Diagram of Test Setup

Same as Section 6.1.

6.2. Test Standard

EN 61000-3-3:2013+A1:2019

6.3. Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
Tmax	4.0%
dt	Not exceed 3.3% for 500ms

6.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

6.5. Test Results

PASS

Please refer to the following page.

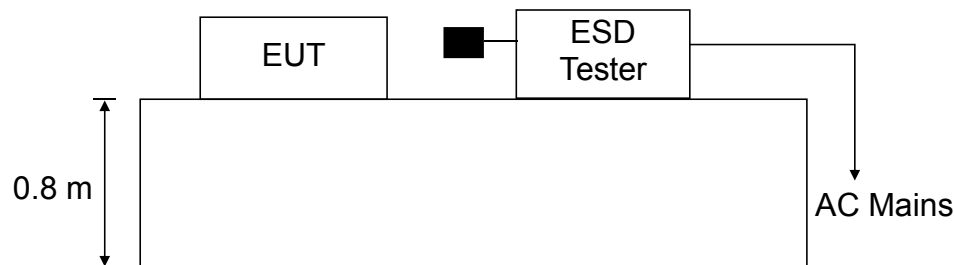
Flicker Test Data			
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	ON

Voltage Fluctuation	Limit	Value
Relative Voltage Change Characteristic Tmax (dc>3%)	500 ms	0 ms
Maximum Relative Voltage Change dmax	4%	0.00
	6%	/
	7%	/
Relative Steady-state Voltage Change dc	3.3%	0.00

Flicker	Limit	Value
Short-term Flicker Indicator Pst	1.0	0.167
Long-term Flicker Indicator Plt	0.65	/

7. ELECTROSTATIC DISCHARGE IMMUNITY TEST

7.1. Block Diagram of Test Setup



7.2. Test Standard

EN 55014-2:2015, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge: ±8KV

Level: 2 / Contact Discharge: ±4KV

7.3. Severity Levels and Performance Criterion

7.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
X	Special	Special

7.3.2 Performance criterion : B

- A.** The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i

- B.** The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C.** Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

7.4.EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN 55014-2:2015, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.
Please refer to Section 2.5.

7.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

7.6.Test Procedure

7.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

7.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied

at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

7.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

7.7. Test Results

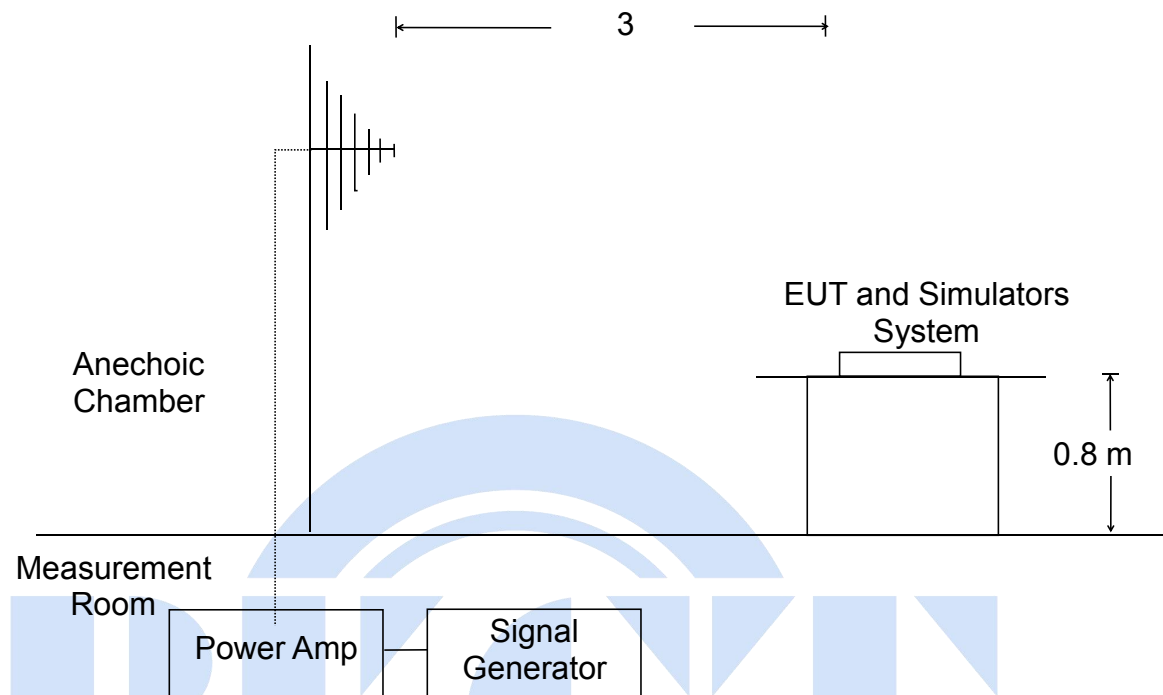
PASS

Please refer to the following page.

ESD Test Data				
Temperature:	25.1°C	Humidity:	56%	
Power Supply :	AC 230V/50Hz	Test Mode:	On	
Air Discharge: ± 8KV				
Contact Discharge: ± 4KV				
Test Points	Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure	±2,4,8 KV	N/A	B	PASS
Slit	±2,4,8 KV	N/A	B	PASS
Button	N/A	±2,4 KV	B	PASS
VCP	N/A	±2,4 KV	B	PASS
HCP	N/A	±2,4 KV	B	PASS
Note: N/A				

8. RF FIELD STRENGTH SUSCEPTIBILITY TEST

8.1. Block Diagram of Test Setup



8.2. Test Standard

EN 55014-2:2015,
EN 61000-4-3: 2006+A1:2008+A2:2010

Severity Level 2, 3V / m

8.3. Severity Levels and Performance Criterion

8.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

8.3.2. Performance criterion: A

- A、 The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B、 The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C、 Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

8.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55014-2:2015, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

8.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 8.1.

8.6. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows :

Condition of Test	Remarks
1. Fielded Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 – 1000 MHz
4. Dwell time of radiated	0.0015 decade/s
5. Waiting Time	1 Sec.

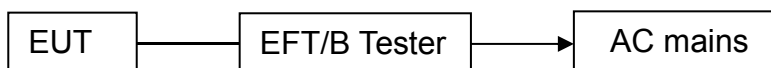
8.7. Test Results

PASS
Please refer to the following page.

R/S Test Data			
Temperature : 25.1°C		Humidity : 56%	
Field Strength: 3 V/m		Criterion: A	
Power Supply: AC 230V/50Hz		Frequency Range: 80 MHz to 1000 MHz	
Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> N/A 1 KHz 80%			
Test Mode : On			
Frequency Range : 80-1000MHz			
Steps	1 %		
	Horizontal	Vertical	Result
Front	A	A	Pass
Right	A	A	Pass
Rear	A	A	Pass
Left	A	A	Pass
Note: N/A			

9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1. Block Diagram of EUT Test Setup



9.2. Test Standard

EN 55014-2:2015, EN 61000-4-4:2012

9.3. Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS

Severity Level:

Open Circuit Output Test Voltage $\pm 10\%$		
Level	On power ports	On I/O(Input/Output) Signal data and control ports
1.	0.5KV	0.25KV
2.	1KV	0.5KV
3.	2KV	1KV
4.	4KV	2KV
X.	Special	Special

Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

9.4.EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55014-2:2015, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

9.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 9.1.

9.6.Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

9.7. Test Results

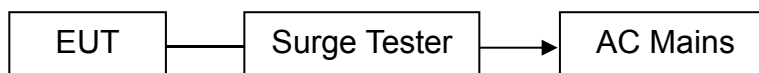
PASS

Please refer to the following page.

EFT Test Data				
Temperature:	25.1℃	Humidity:	56%	
Power Supply :	AC 230V/50Hz	Test Mode:	On	
Coupling Line	Test Voltage		Performance Criterion	Result
	±0.5kV	±1kV		
L	±0.5kV	±1kV	B	PASS
N	±0.5kV	±1kV	B	PASS
L-N	±0.5kV	±1kV	B	PASS
PE	±0.5kV	±1kV	B	N/A
L-PE	±0.5kV	±1kV	B	N/A
N-PE	±0.5kV	±1kV	B	N/A
L-N-PE	±0.5kV	±1kV	B	N/A
DC Line	/	/		/
Note: N/A				

10. SURGE TEST

10.1. Block Diagram of EUT Test Setup



10.2. Test Standard

EN 55014-2:2015, EN61000-4-5:2014

10.3. Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV;

Severity Level: Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)
1.	0.5
2.	1.0
3.	2.0
4.	4.0
X.	Special

Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

10.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55014-2:2015, EN61000-4-5:2014, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

10.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

10.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

10.7. Test Result

PASS

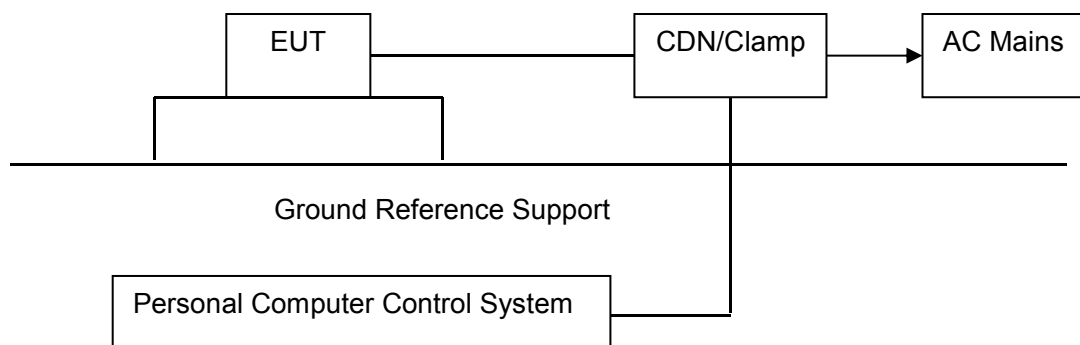
Please refer to the following page.

Surge Test Data						
Temperature:	25.1℃		Humidity:	56%		
Power Supply :	AC 230V/50Hz		Test Mode:	On		
Location	Polarity	Phase Angle	No of Pulse	Pulse Voltage (KV)	Performance Criterion	Result
L-N	+	90	5	1	B	Pass
	-	90	5	1		Pass
	+	270	5	1		Pass
	-	270	5	1		Pass
L-PE	+	90	5	2		N/A
	-	90	5	2		N/A
	+	270	5	2		N/A
	-	270	5	2		N/A
N-PE	+	90	5	2		N/A
	-	90	5	2		N/A
	+	270	5	2		N/A
	-	270	5	2		N/A

Note: N/A

11. INJECTED CURRENTS SUSCEPTIBILITY TEST

11.1. Block Diagram of EUT Test Setup



11.2. Test Standard

EN 55014-2:2015, EN61000-4-6:2014

11.3. Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz ~ 80MHz

Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
X.	Special

Performance criterion: A

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

11.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.8.

11.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

11.6. Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.

- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
- 7) The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.7. Test Result

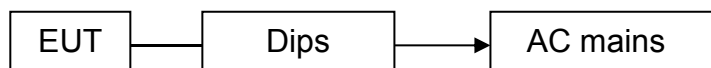
PASS

Please refer to the following page.

CS Test Data						
Temperature:		25.1°C		Humidity:		56%
Power Supply :		AC 230V/50Hz		Test Mode:		On
Frequency Range(MHz)	Injected Position	Strength	Modulation Signal	Freq. Step	Performance Criterion	Result
150KHz ~ 80MHz	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	A	Pass
150KHz ~ 80MHz	DC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	/	/
Note: N/A						

12. VOLTAGE DIPS AND INTERRUPTIONS TEST

12.1. Block Diagram of EUT Test Setup



12.2. Test Standard

EN 55014-2:2015, EN61000-4-11:2004

12.3. Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

- Voltage Dips.
- Voltage Interruptions.

Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dips	70	% Reduction period	C
	25		
Voltage Interruptions	40	% Reduction period	C
	10		
	0	% Reduction period	C
	0.5	% Reduction period	C

Performance criterion: B, C, C

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

12.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.7.

12.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.7 except the test set up replaced as Section 12.1.

12.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 12.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

12.7. Test Result

PASS

Please refer to the following page.

DIPS Test Data			
Temperature:	25.1°C	Humidity:	56%
Power Supply :	AC 230V/50Hz	Test Mode:	On
Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dips	70	% Reduction period	C
	25		
	40 10	% Reduction period	C
Voltage Interruptions	0 0.5	% Reduction period	C

13. EUT PHOTOGRAPHS

Photo 1



Photo 2



Photo 3

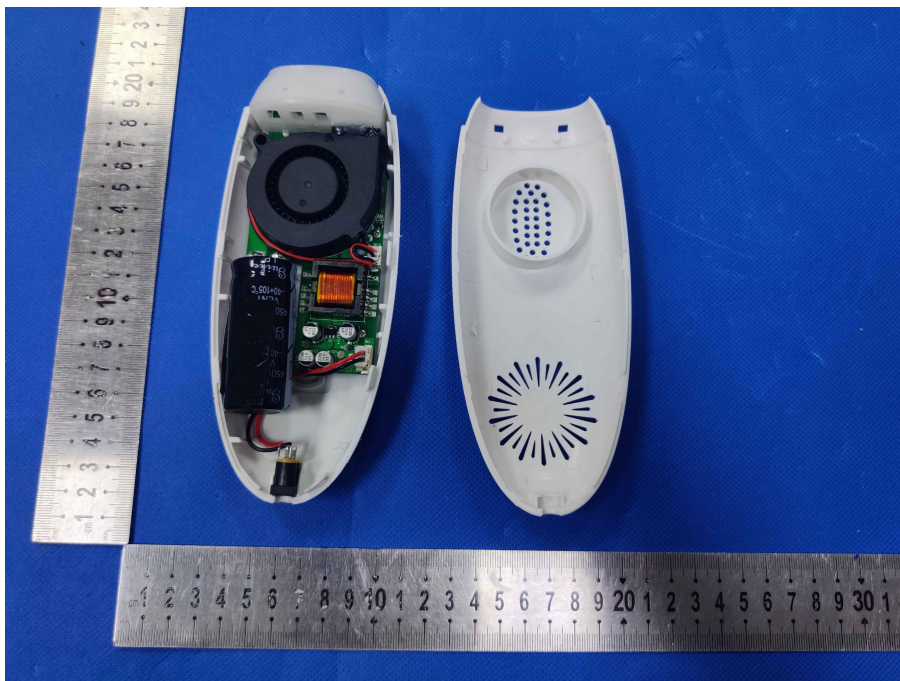
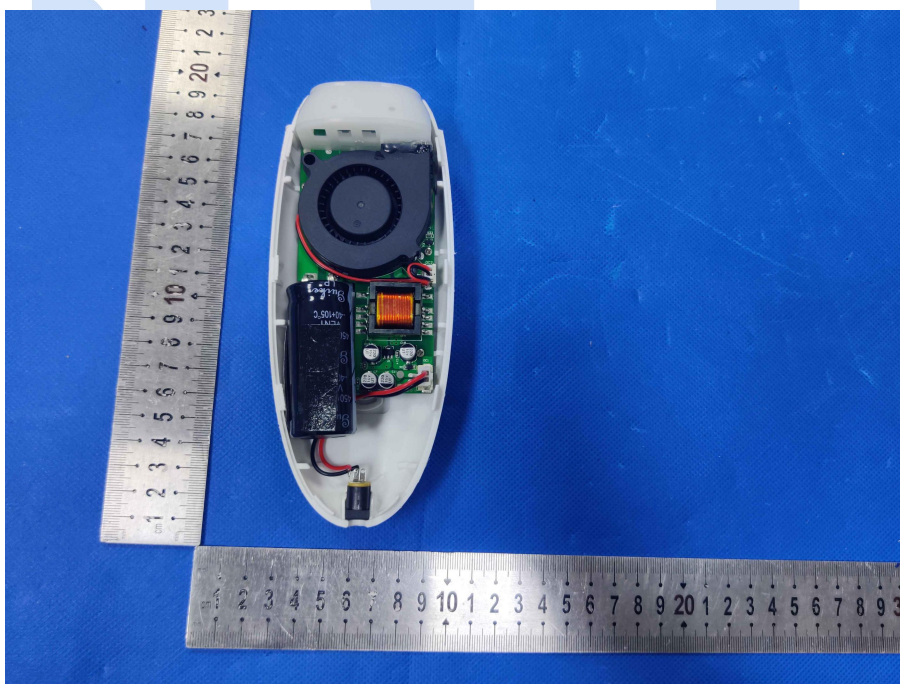


Photo 4



*** END OF REPORT ***